

JAN 29 2004

PATENT TRADEMARK OFFICE
U.S. DEPARTMENT OF COMMERCELIST OF REFERENCES CITED BY APPLICANT
(Use separate sheets if necessary)

ATTY. DOCKET NO.:	APPLICATION NO.:
88265-7027	10/661,388
APPLICANT:	
Zheng et al.	

FILING DATE:	GROUP:
September 11, 2003	1761

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WAW	AA	5,922,380	07/1999	Takihara et al.	A23C	009/14	
WAW	AB	5,364,555	11/1994	Zenner et al.	252	188.28	
WAW	AC	4,897,273	01/1990	Kotaki et al.	426	118	
WAW	AD	4,539,216	09/1985	Tsc	426	597	
WAW	AE	4,287,995	09/1981	Moriya	215	228	
WAW	AF	3,540,889	11/1970	Clinton et al.	99	71	
WAW	AG	3,482,987	12/1969	Pitchon et al.	426	460	
WAW	AH	2001/0008647 A1	9/2001	Belrhlid et al	426	535	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
WAW	AI	EP 0 963 706 w/ English Abstract)	12/1999	Europe			X
WAW	AJ	EP 0861596	09/1998	Europe			X
WAW	AK	EP0328336	08/1989	Europe			X
WAW	AL	WO9518540	07/1995	PCT			X
WAW	AM	WO9611861	04/1996	PCT			X
WAW	AN	08182486	07/1996	Japan (abstract)			X
WAW	AO	62278948	12/1987	Japan (abstract)			X
WAW	AP	1109277	04/1995	China (abstract)			X
WAW	AQ	640241	07/1950	Great Britian			X
WAW	AR	44914		Hungary			X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

WAW	AS	Holscher, W. et al, XP008007644, "Investigations of Roasted Coffee Freshness With An Improved Headspace Technique-Aromafrische Mittles Einer Vergesserten Headspace-Methodik", Forschung, vol. 195, no. 1, 1992, pages 33-38,
WAW	AT	Semmelroch, P. et al., XP000602989 "Analysis of Roasted Coffee Powders And Brews By Gas Chromatography-Olfactometry of Headspace Samples" Lebensmittel Wissenschaft Und Technologies, vol. 28, no. 3, 1995, pages 310-313,

EXAMINER

Leslie Wong

DATE CONSIDERED

6/9/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				ATTY. DOCKET NO.:	APPLICATION SERIAL NO.:		
				88265-7027			
				APPLICANT:	Ying Zheng et al.		
				FILING DATE:	GROUP:		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
W	AA	2,892,718	6/1959	Irwin M. Stone	99	48	
W	AB	3,421,906	1/1969	Ismar M. Reich et al.	99	152	
W	AC	4,738,380	3/1983	Scarpellino et al.	426	533	
W	AD	5,182,194	1/1993	Kerkenaar et al.	435	130	
W	AE	5,578,470	11/1996	Kerkenaar et al.	435	130	
W	AF	5,888,562	3/1999	Hansen et al.	426	45	
W	AG	6,319,537	11/2001	Cheng et al.	426	594	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES <input type="checkbox"/> NO <input type="checkbox"/>
W	AH	0 277 688	8/1988	Europe			X
W	AI	0 934 702	8/1999	Europe			X
W	AJ	JP 08196212 (with English Abstract)	8/1996	Japan			X
W	AK	WO00/69274	11/2000	PCT			X
	AL						
	AM						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>Leslie Wong</i>				DATE CONSIDERED <i>6/9/04</i>			
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